Notice of References Cited

Application/Control No.

10/772,882

Applicant(s)/Patent Under Reexamination SAXLER, ADAM WILLIAM

Examiner

Jerome Jackson Jr.

Applicant(s)/Patent Under Reexamination SAXLER, ADAM WILLIAM

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C,	US-			
	D	US-			·
	E	US-		·	
	F	US-			
	G	US-			- "
	н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Country	Name	Classification
	N					
	0					
	Р				-	
	Q					
	·R					
	S				·	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
_	U	Adesida et al "AlGaN/GaNApplications", Proc. 6th Int. Conf. Solid-State and Int. Cir. Tech. Vol.2 pp. 1163-1168 22-25 Oct. 2001
-	V	Chen et al, "High-TransconductanceMOVPE", IEEE Elec. Dev. Lett. Vol. 10 No. 4 April 1989, pp. 162-164.
	w	Wang et al, "ModfetEffects", IEEE Trans. Elec. Dev. Vol. 36 No. 9 Sept. 1989, pp 1847-1850.
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.